

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/924,054	SAITO, HIROYUKI	
Examiner	Art Unit	
John L. Shew	2664	

	SEAR	CHED	
Class	Subclass	Date	Examiner
340	2.1,2.23	2/6/2006	JS
	2.24,3.1		
370	229,230.1	2/6/2006	JS
	232,233		
	235,237		
	238,238.1		
·	. 252,351		
	389,395.1		
	395.21		
	395.32		
	395.41		
	400,468		
	477,537		
	538,540		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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Search	Notes	(continued)
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09/924,054	SAITO, HIROYUKI	
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SEARCHED			
Class	Subclass	Date	Examiner
709	220,221	2/6/2006	JS
	222,225		
	226		
709	238,239	2/7/2006	JS

INTERFERENCE SEARCHED			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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